Precision Analog Microcontroller, 14-Bit Analog I/O with MDIO Interface, ARM Cortex-M3

Data Sheet

ADuCM320

FEATURES

- Analog input/output
  - Multichannel, 14-bit, 1 MSPS analog-to-digital converter (ADC)
    - Up to 16 ADC input channels
    - 0 V to VREF analog input range
    - Fully differential and single-ended modes
    - AV_{DD} and IOV_{DD} monitors
  - 12-bit voltage output digital-to-analog converters (VDACs)
    - 8 VDACs with a range of 0 V to 2.5 V or AV_{DD} outputs
  - 12-bit current output DACs (IDACs)
    - 4 IDACS with a range of 0 mA to 150 mA outputs
  - Voltage comparator
- Microcontroller
  - ARM Cortex-M3 processor, 32-bit RISC architecture
  - Serial wire port supports code download and debug
- Clocking options
  - 80 MHz PLL with programmable divider
  - Trimmed on-chip oscillator (±3%)
  - External 16 MHz crystal option
  - External clock source up to 80 MHz
- Memory
  - 2 × 128 kB independent Flash/EE memories
  - 10,000 cycle Flash/EE endurance
  - 20-year Flash/EE retention
  - 32 kB SRAM
- Software triggered in-circuit reprogrammability via management data input/output (MDIO)
- On-chip peripherals
  - MDIO slave up to 4 MHz
  - 2 × I^2C, 2 × SPI, UART
  - Multiple general-purpose input/output (GPIO) pins: 3.6 V compliant
  - 7 × 1.2 V compatible when used for MDIO
  - 32-element programmable logic array (PLA)
  - 3 general-purpose timers
  - Wake-up timer
  - Watchdog timer
  - 16-bit pulse width modulator (PWM)
- Power
  - Supply range: 2.9 V to 3.6 V, and 1.8 V to 2.5 V for IDACs
  - Flexible operating modes for low power applications
- Packages and temperature range
  - 6 mm × 6mm, 96-ball CSP_BGA package
  - Fully specified for −40°C to +85°C ambient operation
- Tools
  - Low cost QuickStart development system
  - Full third party support

APPLICATIONS

- Optical networking

Rev. 0 Document Feedback

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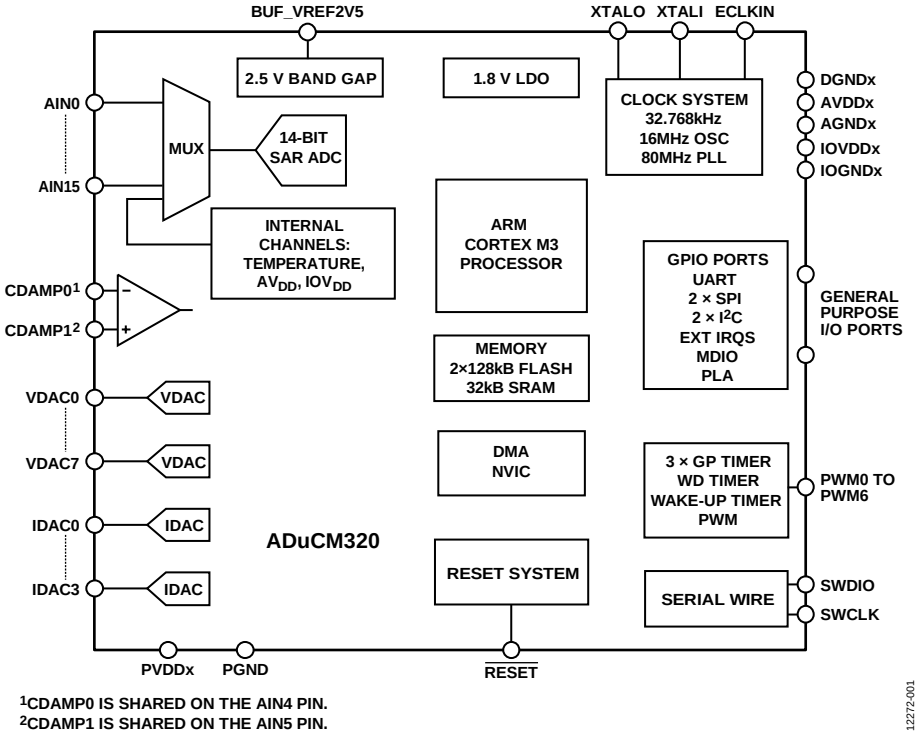
REVISION HISTORY

6/14—Revision 0: Initial Version

FUNCTIONAL BLOCK DIAGRAM



[1]CDAMP0 IS SHARED ON THE AIN4 PIN.
[2]CDAMP1 IS SHARED ON THE AIN5 PIN.

Figure 1.

GENERAL DESCRIPTION

The ADuCM320 is a fully integrated single package device that incorporates high performance analog peripherals together with digital peripherals controlled by an 80 MHz ARM® Cortex™-M3 processor and integral flash for code and data.

The ADC on the ADuCM320 provides 14-bit, 1 MSPS data acquisition on up to 16 input pins that can be programmed for single-ended or differential operation. The voltage at the IDAC output pins can also be measured by the ADC, which is useful for controlling the power consumption of the current DACs. Additionally, chip temperature and supply voltages can be measured.

The ADC input voltage is 0 V to VREF. A sequencer is provided, which allows a user to select a set of ADC channels to be measured in sequence without software involvement during the sequence. The sequence can optionally repeat automatically at a user selectable rate.

Up to eight VDACs are provided with output ranges that are programmable to one of two voltage ranges. The VDAC outputs have the enhanced feature of retaining their output voltages during a watchdog or software reset sequence.

Four IDAC sources are provided. The output currents are programmable with ranges of 0 mA to 150 mA. A low drift band gap reference and voltage comparator complete the analog input peripheral set.

The ADuCM320 has a low power ARM Cortex-M3 processor and a 32-bit RISC machine that offers up to 100 MIPS peak performance. Also integrated on chip are 2 × 128 kB Flash/EE memory and 32 kB of SRAM. The flash comprises two separate 128 kB blocks supporting execution from one flash block and simultaneous writing/erasing of the other flash block.

The ADuCM320 operates from an on-chip oscillator or a 16 MHz external crystal and a PLL at 80 MHz. This clock can optionally be divided down to reduce current consumption. Additional low power modes can be set via software. In normal operating mode, the ADuCM320 digital core consumes about 300 µA per MHz.

The device includes an MDIO interface capable of operating at up to 4 MHz. The capability to simultaneously execute from one flash block and write/erase the other flash block makes the ADuCM320 ideal for 10G, 40G, and 100G optical applications. User programming is eased by receiving interrupts after PHYADR, DEVADD, and end of frame, and by incorporating PHYADR and DEVADD hardware comparators. In addition, the nonerasable kernel code plus flags in user flash provide assistance by allowing user code to robustly switch between the two blocks of user flash code and data spaces, as required for MDIO.

The ADuCM320 integrates a range of on-chip peripherals that can be configured under software control, as required in the application. These peripherals include 1 × UART, 2 × I^2C, and 2 × SPI serial I/O communication controllers, GPIO, 32-element programmable logic array, 3 general-purpose timers, plus a wake-up timer and system watchdog timer. A 16-bit PWM with seven output channels is also provided.

GPIO pins on the device power up in input mode with an internal pull-up resistor. In output mode, the software chooses between open-drain mode and push-pull mode. The outputs can drive at least 4 mA. The pull-up resistors can be disabled and enabled in software. In GPIO mode, the inputs can be enabled to monitor the pins. The GPIO pins can also be programmed to handle digital or analog peripheral signals, in which case the pin characteristics are matched to the specific requirement.

A large support ecosystem is available for the ARM Cortex-M3 processor to ease product development of the ADuCM320. Access is via the ARM serial wire debug port (SW-DP). On-chip factory firmware supports in-circuit serial download via MDIO. These features are incorporated into a low cost QuickStart™ development system supporting this precision analog microcontroller family.

SPECIFICATIONS

MICROCONTROLLER ELECTRICAL SPECIFICATIONS

AV_{DD} = IOV_{DD} = VDD1 = 2.9 V to 3.6 V (see Figure 8) maximum difference between supplies = 0.3 V, VREF = 2.5 V internal reference, f_{CORE} = 80 MHz, T_A = −40°C to +85°C, unless otherwise noted. PVDDx for IDACs = 1.8 V to 2.5 V. Power-up sequence must be VDD1, IOVDDx, AVDDx, and then PVDDx, but no delays in the sequence are required.

Table 1.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
ADC CHANNEL SPECIFICATIONS						Single-ended mode, unless otherwise stated
ADC Power-Up Time			5		µs	
Data Rate	f_{SAMPLE}			1	MSPS	
DC Accuracy[1]		14			Bits	1 LSB = 2.5 V/2^{14}
Resolution[1]		16			Bits	Number of data bits
Integral Nonlinearity	INL		±1.75		LSB	2.5 V internal reference; 1 LSB = 2.5 V/2^{14}
			±1.75		LSB	2.5 V external reference; 1 LSB = 2.5 V/2^{14}
Differential Nonlinearity	DNL		±0.75	+1/−0.99	LSB	2.5 V internal reference; 1 LSB = 2.5 V/2^{14}
			±0.75		LSB	2.5 V external reference; 1 LSB = 2.5 V/2^{14}
DC Code Distribution			±3		LSB	ADC input 1.25 V; 1 LSB = 2.5 V/2^{14}
ADC ENDPOINT ERRORS						
Offset Error						
Input Buffer Off			±200		µV	
Drift[1]		−2.25		+1.2	µV/°C	Using 2.5 V external reference
Input Buffer On			−250		µV	
Drift[1]		−2.6		+2	µV/°C	Using 2.5 V external reference
Match			±1		LSB	Matching compared to AIN8
Full-Scale Error						
Input Buffer Off			±400		µV	
Gain Drift[1]		−4		+2	µV/°C	Full-scale error drift minus offset error drift
Input Buffer On			−350		µV	
Gain Drift[1]		−4.5		+3	µV/°C	Full-scale error drift minus offset error drift
Match			±1		LSB	
ADC DYNAMIC PERFORMANCE						f_{IN} = 665.25 Hz sine wave, f_{SAMPLE} = 100 kSPS; input filter = 15 Ω, 2 nF
Signal-to-Noise Ratio	SNR					Includes distortion and noise components
Input Buffer						
Disabled			80		dB	
Enabled			74		dB	
Total Harmonic Distortion	THD					
Input Buffer						
Disabled			−86		dB	
Enabled			−78		dB	
Peak Harmonic or Spurious Noise			−88		dB	
Channel-to-Channel Crosstalk			−90		dB	Measured on adjacent channels

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
ADC INPUT						Input buffer not enabled
Input Voltage Ranges						
Differential Mode[1]		−VREF		+VREF	V	Voltage between differential pins
Compliance[1]		AGND4		AVDD4		
Common Mode[1]		0.9		1.6	V	
Single-Ended Mode[1]		AGND4		VREF	V	
Leakage Current						
AIN0 to AIN4, AIN6 to AIN15			±1.5		nA	
AIN5			±20		nA	Pin shared with comparator
Input Current			±9		µA/V	At 1 MSPS; buffer off
			±6		µA/V	≤800 kSPS; buffer off
			±4		µA/V	500 kSPS; buffer off; ADCCNVC[25:16] = 0x1E
Input Capacitance			20		pF	During ADC acquisition
ADC INPUT BUFFER[2]						When enabled by software
Voltage Compliance[1]		0.15		2.5	V	Reduced accuracy below 0.15 V
Input Current			±100		nA	V_{IN} = 0.15 V to 2.5 V, ADC converting
ON-CHIP VOLTAGE REFERENCE			2.51		V	0.47 µF from VREF_1V2 to AGND4; reference is measured with all ADCs, VDACs, and IDACs enabled
Accuracy				±5	mV	T_A = 25°C
Reference Temperature Coefficient[1]		−34	−15	+4	ppm/°C	
Power Supply Rejection Ratio	PSRR		60		dB	
Output Impedance			10		Ω	T_A = 25°C
Internal V_{REF} Power-On Time			50		ms	
EXTERNAL REFERENCE INPUT						
Range[1]		1.8		2.5	V	ADC
BUFFERED REFFERNCE OUTPUT						
Output Voltage			2.504		V	
Accuracy			±8		mV	T_A = 25°C, load = 1.2 mA
Reference Temperature Coefficient[1]		−55	−5	+40	µV/°C	100 nF from BUF_VREF2V5 to AGND4
Load Current[1]				1.2	mA	
VDAC CHANNEL SPECIFICATIONS						R_L = 5 kΩ, C_L = 100 pF
DC Accuracy[1]		12			Bits	1 LSB = 2.5 V/2^{12}
Resolution[1]		12			Bits	Number of data bits
Relative Accuracy[3]	INL		±4		LSB	1 LSB = 2.5 V/2^{12}
Differential Nonlinearity[3]	DNL			+1/−0.99	LSB	Guaranteed monotonic, 1 LSB = 2.5 V/2^{12}
Offset Error			±3	±15	mV	2.5 V internal reference, DAC Output Code 0
Drift			±13		µV/°C	
Gain Error[4]			±0.3	±0.85	%	0 V to internal V_{REF} range
			±0.4	±1	%	0 V to AVDD range
Drift			6.5		ppm/°C	Excluding reference drift
Mismatch			0.1		%	% of full scale on DAC0
Analog Outputs						
Output Voltage Range 1[1]		0.15		2.5	V	
Output Voltage Range 2[1]		0.15		AVDDx− 0.15	V	
Output Impedance			2		Ω	
DAC AC Characteristics						

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Output Settling Time			10		µs	Settled to ±1 LSB
Glitch Energy			±20		nV-sec	1 LSB change when the maximum number of bits changes simultaneously in the DACxDAT register
IDAC CHANNEL SPECIFICATIONS						
Resolution[1]		14			Bits	Combination of overlapping 11 bits and 5 bits
Full-Scale Output[1]			150		mA	
Supply Voltage Each Channel[1]		1.8		2.5	V	Separate PVDDx supply for each channel
Output Compliance Range						
IDAC0, IDAC1		0.4		PVDDx − 400 mV	V	See Figure 5
IDAC2, IDAC3		0.4		PVDDx − 250 mV	V	See Figure 5
Full-Scale Error						IDAC set to 85% of full scale
IDAC0, IDAC1				±0.75	%	25°C to 105°C range
				±3.5	%	−40°C to +105°C range
IDAC2, IDAC3				±0.75	%	−40°C to +105°C range
Full-Scale Error Drift						
IDAC0, IDAC1						Internal V_{REF}
−40°C to +85°C			25		µA/°C	
25°C to 85°C			5		µA/°C	
IDAC2, IDAC3			2		µA/°C	Internal V_{REF}
Integral Nonlinearity	INL		±3	±6	LSB	1 LSB = 150 mA/2[11]
Differential Nonlinearity	DNL			+1/−0.99	LSB	Guaranteed 11-bit monotonic, 1 LSB = 150 mA/2[11]
Zero-Scale Error			±50		µA	
Zero-Scale Error Drift						
IDAC0, IDAC1			±300		nA/°C	
IDAC2, IDAC3			±800		nA/°C	
Noise Current			2		µA	IDACxCON[5:2] = 0
Pull-Down Current		−220	−165	−100	µA	When enabled
Settling Time						IDACxCON[5:2] = 0
To 0.1%			100		µs	±4 mA change from midscale
To 1%			50		µs	±4 mA change from midscale
Full Scale to 0 mA			20		µs	Pull-down enabled
Overheat Shutdown			135		°C	Junction temperature
PVDD ACPSRR						IDACxCON[5:2] = 0
100 Hz			51		dB	
1 kHz			45		dB	
10 kHz			25		dB	
100 kHz			10		dB	
COMPARATOR						
Input						
Offset Voltage			±10		mV	
Bias Current			1		µA	
Voltage Range[1]		AGNDx		AVDDx − 1.2	V	
Capacitance			7		pF	
Hysteresis[1]		8.5		15	mV	When enabled in software
Response Time			3		µs	Software selectable
TEMPERATURE SENSOR						Indicates die temperature, see Figure 3
Resolution			0.5		°C	When precision calibrated by the user[5]
Accuracy[1]		1.34		1.43	V	ADC measured voltage for temperature sensor channel without calibration, t = 25°C

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
POWER-ON RESET	POR		2.85	2.9	V	
WATCHDOG TIMER	WDT					
Timeout Period			32		sec	Default at power-up
FLASH/EE MEMORY						
Endurance[1]		10,000			Cycles	
Data Retention[1]		20			Years	T_J = 85°C
DIGITAL INPUTS						
Input Leakage Current						
Logic 1 GPIO			1		nA	$V_{IH} = V_{DD}$, pull-up resistor disabled
Logic 0 GPIO			10		nA	V_{IL} = 0 V, pull-up resistor disabled
PRTADDRx						
MCLK Input Leakage Current			16		µA	V_{IN} = 0 to 1.8 V, due to weak pull-up resistors to 1.8 V
MCLK Voltage				1.5	V	External resistor < 75 kΩ to ground
		0.84		1.5	V	External resistor 91 kΩ ± 1% to ground, range for CFP MSA high[1]
Input Capacitance, All Pins Except MCK, MDIO, PRTADDRx, and XTALx			10		pF	
Input Capacitance						
MCK, PRTADDRx			6.5		pF	
MDIO			8.5		pF	
Pin Capacitance						
XTALI			5		pF	
XTALO			5		pF	
LOGIC INPUTS						
GPIO Input Voltage						
Low	V_{INL}			0.25 × IOVDDx	V	
High	V_{INH}	0.58 × IOVDDx			V	
MDIO						
Input Voltage						
Low	V_{INL}			0.36	V	
High	V_{INH}	0.84			V	
Setup Time				10	ns	
Hold Time				10	ns	
XTALI Input Voltage						
Low	V_{INL}		1.1		V	
High	V_{INH}		1.7		V	
CURRENT						
Pull-Up Current		30		120	µA	V_{IN} = 0 V, see Figure 4
Pull-Down Current		30		100	µA	V_{IN} = 3.3 V, see Figure 4
LOGIC OUTPUTS						All digital outputs excluding XTALO
GPIO Output Voltage[6]						
High	V_{OH}	IOVDDx – 0.4			V	I_{SOURCE} = 2 mA
Low	V_{OL}			0.4	V	I_{SINK} = 2 mA
MDIO						
Output Voltage						
High	V_{OH}	1.0			V	I_{SOURCE} = 4 mA
Low	V_{OL}			0.2	V	I_{SINK} = 4 mA
Delay Time				150	ns	
Short-Circuit Current[1]			11		mA	See Figure 7

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
OSCILLATORS						
Internal System Oscillator			16		MHz	
Accuracy			±0.5	±3	%	
System PLL			80		MHz	Main system clock
External Crystal Oscillator			16		MHz	Can be selected in place of internal oscillator
32 kHz Internal Oscillator			32.768		kHz	Use for watchdog
Accuracy			±5	±20	%	
External Clock		0.05		80	MHz	Can be selected in place of PLL
START-UP TIME						Processor clock = 80 MHz
At Power-On			40		ms	POR to first user code execution
After Other Reset			1.5		ms	Reset to first user code execution
From All Power-Down Modes			1.25		µs	
PROGRAMMABLE LOGIC ARRAY	PLA					
Propagation Delay						
Pin			12		ns	From input pin to output pin
Element			2.5		ns	Per PLA cell
EXTERNAL INTERRUPTS						
Pulse Width[1]						
Level Triggered		7			ns	
Edge Triggered		1			ns	
POWER REQUIREMENTS[7]						
Power Supply Voltage Range						
AVDDx to AGNDx and IOVDDx to DGNDx[1]		2.9	3.3	3.6	V	
Analog Power Supply Currents						
AVDDx Current			6.3		mA	Analog peripherals in idle mode
Digital Power Supply Current						
IOVDDx Current in Normal Mode			4		mA	All GPIO pull-up resistors enabled
VDDx Current						
Normal Mode			29		mA	CD = 0 (80 MHz clock) executing typical code
			20		mA	CD = 1 executing typical code
			10		mA	CD = 7 executing typical code
CORE_SLEEP Mode			16		mA	
SYS_SLEEP Mode			8		mA	
Hibernate Mode			6.6		mA	
Additional Power Supply Currents						
ADC			4.1		mA	Continuously converting at 100 kSPS
ADC Input Buffer			4.0		mA	Both buffers enabled
IDAC			16.5		mA	Excluding load current
DAC			340		µA	Per powered up DAC, excluding load current
Thermal Performance						
Impedance Junction to Ambient			45		°C/W	JEDEC 2S2P

[1] These numbers are not production tested but are guaranteed by design and/or characterization data at production release.
[2] Enabling the input buffer changes the ADC input characteristics as described in this subsection.
[3] DAC linearity is calculated using a reduced code range of 100 to 3900.
[4] DAC gain error is calculated using a reduced code range of 100 to an internal 2.5 V V_{REF}.
[5] Due to self heating, internal temperature measurements cannot be used to predict external temperatures. This value is only relevant after user calibration and only for internal and external conditions identical to those at calibration.
[6] The average current from all GPIO pins must not exceed 3 mA per pin.
[7] Power figures exclude any load currents to external circuits.

ABSOLUTE MAXIMUM RATINGS

All requirements applicable to each pin must be met. Pins that can be either analog or digital, that is, that have two types indicated in the pin descriptions, must meet the limits for both types. For pin types, see Table 3.

When powered up, it is required that all ground pins plus ADC_REFN be connected together to a node referred to as GND in Table 2. The limits that are listed must be reduced by any difference between any GNDs. Also, it is required that AVDD3 is connected to AVDD4 and that IOVDD1 to IOVDD3 are connected together. Until IOVDDx reaches the minimum operating voltage level, the limits for any Type I pin to GND are −0.3 V to +3.9 V.

Table 2. Absolute Maximum Ratings

Parameter	Rating
Any AVDDx, IOVDDx, VDD1 to GND	−0.3 V to +3.9 V
Between Any of AVDDx, IOVDDx, and VDD1 Pins	−0.3 V to +0.3 V
Any PVDDx to GND	−0.3 V to +2.8 V
Any Type I Pin to GND	−0.3 V to IOVDDx + 0.3 V
Any Type AI Pin to GND	−0.3 V to AVDDx + 0.3 V
Any IDACx, CDAMPx, IDACTST, IREF to GND	−0.3 V to PVDDx + 0.3 V
MDIO, MCK, PRTADDR0-4 in MDIO Mode to GND	−0.3 V to +2.1 V
ADC_REFP to GND	−0.3 V to AVDDx + 0.3 V
Total Positive GPIO Pin Currents	0 mA to 30 mA
Total Negative GPIO Pin Currents	−30 mA to 0 mA
Maximum Power Dissipation	1 W
Operating Ambient Temperature	40°C to 85°C
Storage Temperature	−65°C to +160°C
Operating Junction Temperature	40°C to 120°C
ESD HBM	2 kV
ESD FICDM	1 kV

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

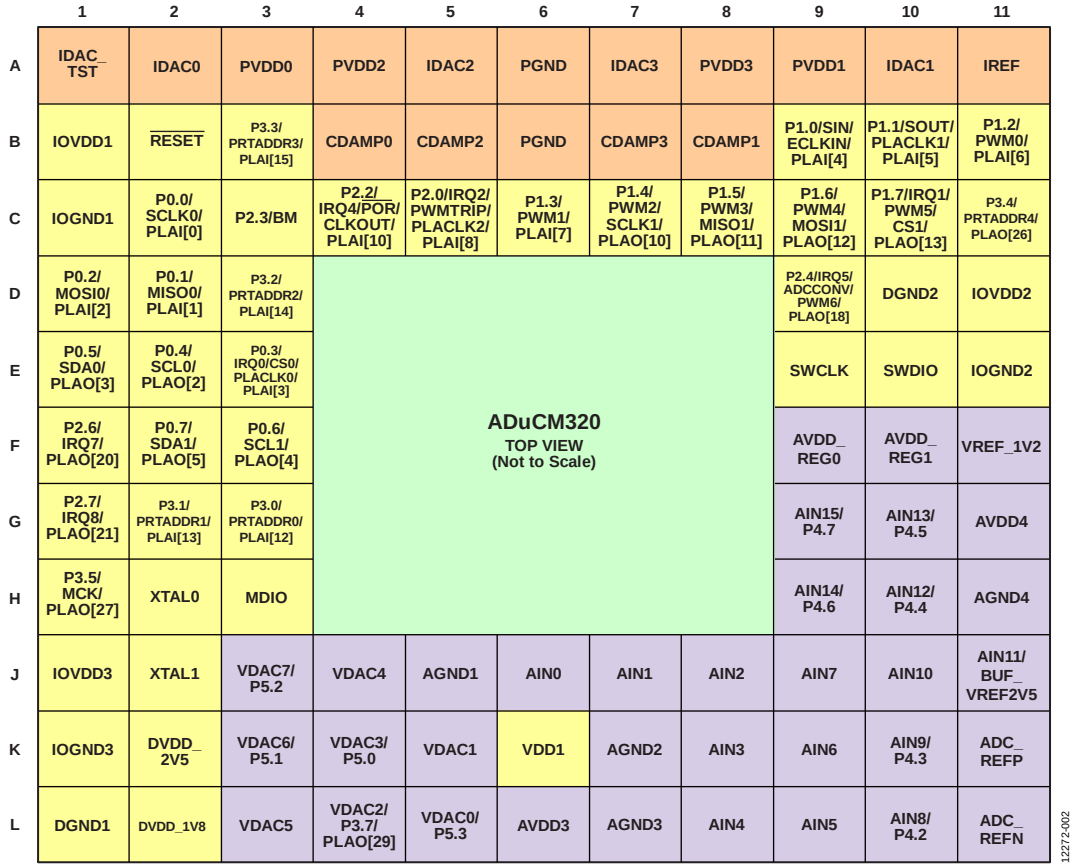


Figure 2. Pin Configuration

Table 3. Pin Function Descriptions

Pin No.	Mnemonic	Type[1]	Description
B2	$\overline{\text{RESET}}$	I	Reset Input (Active Low). An internal pull-up resistor is included.
C2	P0.0/SCLK0/PLAI[0]	I/O	Digital I/O Port 0.0 (P0.0). SPI0 Clock (SCLK0). Input to PLA Element 0 (PLAI[0]).
D2	P0.1/MISO0/PLAI[1]	I/O	Digital I/O Port 0.1 (P0.1). SPI0 Master In, Slave Out (MISO0). Input to PLA Element 1 (PLAI[1]).
D1	P0.2/MOSI0/PLAI[2]	I/O	Digital I/O Port 0.2 (P0.2). SPI0 Master Out, Slave In (MOSI0). Input to PLA Element 2 (PLAI[2]).
E3	P0.3/IRQ0/CS0/PLACLK0/PLAI[3]	I/O	Digital I/O Port 0.3 (P0.3). External Interrupt 0 (IRQ0). SPI0 Chip Select 0 (CS0). When using SPI0, configure this pin as CS0. PLA Clock 0 (PLACLK0). Input to PLA Element 3 (PLAI[3]).
E2	P0.4/SCL0/PLAO[2]	I/O	Digital I/O Port 0.4 (P0.4). I^2C0 Serial Clock (SCL0). Output of PLA Element 2 (PLAO[2]).
E1	P0.5/SDA0/PLAO[3]	I/O	Digital I/O Port 0.5 (P0.5). I^2C0 Serial Data (SDA0). Output of PLA Element 3 (PLAO[3]).

Pin No.	Mnemonic	Type[1]	Description
F3	P0.6/SCL1/PLAO[4]	I/O	Digital I/O Port 0.6 (P0.6). I²C1 Serial Clock (SCL1). Output of PLA Element 4 (PLAO[4]).
F2	P0.7/SDA1/PLAO[5]	I/O	Digital I/O Port 0.7 (P0.7). I²C1 Serial Data (SDA1). Output of PLA Element 5 (PLAO[5]).
B9	P1.0/SIN/ECLKIN/PLAI[4]	I/O	Digital I/O Port 1.0 (P1.0). UART Input (SIN). External Input Clock (ECLKIN). Input to PLA Element 4 (PLAI[4]).
B10	P1.1/SOUT/PLACLK1/PLAI[5]	I/O	Digital I/O Port 1.1 (P1.1). UART Output (SOUT) PLA Clock 1(PLACLK1). Input to PLA Element 5 (PLAI[5]).
B11	P1.2/PWM0/PLAI[6]	I/O	Digital I/O Port 1.2 (P1.2). PWM Output 0 (PWM0). Input to PLA Element 6 (PLAI[6]).
C6	P1.3/PWM1/PLAI[7]	I/O	Digital I/O Port 1.3 (P1.3). PWM Output 1 (PWM1). Input to PLA Element 7 (PLAI[7]).
C7	P1.4/PWM2/SCLK1/PLAO[10]	I/O	Digital I/O Port 1.4 (P1.4). PWM Output 2 (PWM2). SPI1 Clock (SCLK1). Output of PLA Element 10 (PLAO[10]).
C8	P1.5/PWM3/MISO1/PLAO[11]	I/O	Digital I/O Port 1.5 (P1.5). PWM Output 3 (PWM3). SPI1 Master In, Slave Out (MISO1). Output of PLA Element 11 (PLAO[11]).
C9	P1.6/PWM4/MOSI1/PLAO[12]	I/O	Digital I/O Port 1.6 (P1.6). PWM Output 4 (PWM4). SPI1 Master Out, Slave Input (MOSI1). Output of PLA Element 12 (PLAO[12]).
C10	P1.7/IRQ1/PWM5/CS1/PLAO[13]	I/O	Digital I/O Port 1.7 (P1.7). External Interrupt 1 (IRQ1). PWM Output 5 (PWM5). SPI1 Chip Select 1 (CS1). When using SPI1, configure this pin as CS1. Output of PLA Element 13 (PLAO[13]).
C5	P2.0/IRQ2/PWMTRIP/PLACLK2/PLAI[8]	I/O	Digital I/O Port 2.0 (P2.0). External Interrupt 2 (IRQ2). PWM Trip (PWMTRIP). PLA Input Clock 2 (PLACLK2). Input to PLA Element 8 (PLAI[8]).
C4	P2.2/IRQ4/$\overline{\text{POR}}$/CLKOUT/PLAI[10]	I/O	Digital I/O Port 2.2 (P2.2). External Interrupt 4 (IRQ4). Reset Output ($\overline{\text{POR}}$). This pin function is an output and it is the default for Pin C4. Clock Output (CLKOUT). Input to PLA Element 10 (PLAI[10]).
C3	P2.3/BM	I/O	Digital I/O Port 2.3 (P2.3). Boot Mode (BM). When this pin is low, the device enters download after the next reset. Pull-up is enabled at power-up.

Pin No.	Mnemonic	Type[1]	Description
D9	P2.4/IRQ5/ADCCONV/PWM6/PLAO[18]	I/O	Digital I/O Port 2.4 (P2.4). External Interrupt 5 (IRQ5). External Input to Start ADC Conversions (ADCCONV). PWM Output 6 (PWM6). Output of PLA Element 18 (PLAO[18]).
F1	P2.6/IRQ7/PLAO[20]	I/O	Digital I/O Port 2.6 (P2.6). External Interrupt 7 (IRQ7). Output of PLA Element 20 (PLAO[20]).
G1	P2.7/IRQ8/PLAO[21]	I/O	Digital I/O Port 2.7 (P2.7). External Interrupt 8 (IRQ8). Output of PLA Element 21 (PLAO[21]).
G3	P3.0/PRTADDR0/PLAI[12]	I/O	Digital I/O Port 3.0 (P3.0). MDIO Port Address Bit 0 (PRTADDR0). See the digital inputs parameter in Table 1 for details. Input to PLA Element 12 (PLAI[12]).
G2	P3.1/PRTADDR1/PLAI[13]	I/O	Digital I/O Port 3.1 (P3.1). MDIO Port Address Bit 1 (PRTADDR1). See the digital inputs parameter in Table 1 for details. Input to PLA Element 13 (PLAI[13]).
D3	P3.2/PRTADDR2/PLAI[14]	I/O	Digital I/O Port 3.2 (P3.2). MDIO Port Address Bit 2 (PRTADDR2). See the digital inputs parameter in Table 1 for details. Input to PLA Element 14 (PLAI[14]).
B3	P3.3/PRTADDR3/PLAI[15]	I/O	Digital I/O Port 3.3 (P3.3). MDIO Port Address Bit 3 (PRTADDR3). See the digital inputs parameter in Table 1 for details. Output of PLA Element 15 (PLAI[15]).
C11	P3.4/PRTADDR4/PLAO[26]	I/O	Digital I/O Port 3.4 (P3.4). MDIO Port Address Bit 4 (PRTADDR4). See the digital inputs parameter in Table 1 for details. Output of PLA Element 26 (PLAO[26]).
H1	P3.5/MCK/PLAO[27]	I/O	Digital I/O Port 3.5 (P3.5). MDIO Clock (MCK) See the digital inputs parameter in Table 1 for more details. Output of PLA Element 27 (PLAO[27]).
H3	MDIO	I/O	MDIO Data.
E9	SWCLK	I	Serial Wire Debug Clock.
E10	SWDIO	I/O	Serial Wire Bidirectional Data.
F11	VREF_1V2	S	1.2 V Reference. This pin cannot be used to source current externally. Connect VREF_1V2 to AGNDx via a 470 nF capacitor.
A11	IREF	AI	IDAC Reference Current. This pin generates the reference current for the IDACs and is set by an external resistor, R_{EXT}. Connect IREF to AGND4.
J6	AIN0	AI	Analog Input 0.
J7	AIN1	AI	Analog Input 1.
J8	AIN2	AI	Analog Input 2.
K8	AIN3	AI	Analog Input 3.
L8	AIN4	AI	Analog Input 4.
L9	AIN5	AI	Analog Input 5. AIN5 can be the −ve input for the comparator.
K9	AIN6	AI	Analog Input 6. AIN6 is also the +ve input for the comparator.
J9	AIN7	AI	Analog Input 7.
L10	AIN8/P4.2	AI/I/O	Analog Input 8 (AIN8). Digital I/O Port 4.2 (P4.2).
K10	AIN9/P4.3	AI/I/O	Analog Input 9 (AIN9). Digital I/O Port 4.3 (P4.3).
J10	AIN10	AI	Analog Input 10.

Pin No.	Mnemonic	Type[1]	Description
J11	AIN11/BUF_VREF2V5	AI/AO	Analog Input 11 (AIN11). Buffered 2.5 V Bias (BUF_VREF2V5). The maximum load = 1.2 mA. Connect BUF_VREF2V5 to AGNDx via a 100 nF capacitor.
H10	AIN12/P4.4	AI/I/O	Analog Input 12 (AIN12). Digital I/O Port 4.4 (P4.4).
G10	AIN13/P4.5	AI/I/O	Analog Input 13 (AIN13). Digital I/O Port 4.5 (P4.5).
H9	AIN14/P4.6	AI/I/O	Analog Input 14 (AIN14). Digital I/O Port 4.6 (P4.6).
G9	AIN15/P4.7	AI/I/O	Analog Input 15 (AIN15). Digital I/O Port 4.7 (P4.7).
L5	VDAC0/P5.3	AO/I/O	Voltage DAC0 Output (VDAC0). Digital I/O Port 5.3 (P5.3).
K5	VDAC1	AO	Voltage DAC1 Output.
L4	VDAC2/P3.7/PLAO[29]	AO/I/O	Voltage DAC2 Output (VDAC2). Digital I/O Port 3.7 (P3.7). Output of PLA Element 29 (PLAO[29]).
K4	VDAC3/P5.0	AO/I/O	Voltage DAC3 Output (VDAC3). Digital I/O Port 5.0 (P5.0).
J4	VDAC4	AO	Voltage DAC4 Output (VDAC4).
L3	VDAC5	AO	Voltage DAC5 Output (VDAC5).
K3	VDAC6/P5.1	AO/I/O	Voltage DAC6 Output (VDAC6). Digital I/O Port 5.1 (P5.1).
J3	VDAC7/P5.2	AO/I/O	Voltage DAC7 Output (VDAC7). Digital I/O Port 5.2 (P5.2).
A2	IDAC0	AO	IDAC0. 0 mA to 150 mA full-scale output.
A3	PVDD0	S	Power for IDAC0.
B4	CDAMP0	AI	Damping Capacitor 0. Connect damping capacitor from this pin to PVDD0.
A10	IDAC1	AO	IDAC1. 0 mA to 150 mA full-scale output.
A9	PVDD1	S	Power for IDAC1.
B8	CDAMP1	AI	Damping Capacitor 1. Connect damping capacitor from this pin to PVDD1.
A5	IDAC2	AO	IDAC2. 0 mA to 150 mA full-scale output.
A4	PVDD2	S	Power for IDAC2.
B5	CDAMP2	AI	Damping Capacitor 2. Connect damping capacitor from this pin to PVDD2.
A7	IDAC3	AO	IDA3C. 0 mA to 150 mA full-scale output.
A8	PVDD3	S	Power for IDAC3.
B7	CDAMP3	AI	Damping Capacitor 3. Connect damping capacitor from this pin to PVDD3.
B6	PGND	S	Power Supply Ground for IDACs.
A6	PGND	S	Power Supply Ground for IDACs.
A1	IDAC_TST	AI/AO	Pin for IDAC Test Purposes. Leave IDAC_TST unconnected.
L2	DVDD_1V8	AO	1.8 V Digital Supply. A 470 nF capacitor to DGND1 must be connected to this pin to stabilize the internal 1.8 V regulator that supplies flash memory and the ARM Cortex-M3 processor.
K2	DVDD_2V5	AO	2.5 V Digital Supply. A 470 nF capacitor to IOGND3 must be connected to this pin to stabilize the internal 2.5 V regulator that supplies the analog digital control.
F9	AVDD_REG0	AO	Analog Regulator 0 Supply. A 470 nF capacitor to AGND4 must be connected to this pin to stabilize the internal 2.5 V regulator that supplies the ADC.
F10	AVDD_REG1	AO	Analog Regulator 1 Supply. Output of 2.5 V on-chip LDO regulator. A 470 nF capacitor to AGND4 must be connected to this pin. This regulator supplies the IDACs.
L1	DGND1	S	Digital Ground 1 for DVDD_1V8.
D10	DGND2	S	Digital Ground 2. Connect to DGND1.
B1	IOVDD1	S	3.3 V GPIO Supply.

Pin No.	Mnemonic	Type[1]	Description
D11	IOVDD2	S	3.3 V GPIO Supply and Interdie Communications.
J1	IOVDD3	S	3.3 V GPIO Supply.
C1	IOGND1	S	Ground for IOVDD1.
E11	IOGND2	S	Ground for IOVDD2.
K1	IOGND3	S	Ground for IOVDD3 and Interdie Communications.
J5	AGND1	S	Analog Ground for VDD1.
K7	AGND2	S	ESD Ground for Pad Ring.
L7	AGND3	S	Ground for AVDD3.
H11	AGND4	S	Ground for AVDD4, AVDD_REG0, and AVDD_REG1.
K6	VDD1	S	3.3 V Supply for Digital Die.
L6	AVDD3	S	VDAC and IDAC Supply (3.3 V).
G11	AVDD4	S	ADC Supply (3.3 V).
L11	ADC_REFN	AO/A	Decoupling Capacitor Connection for ADC Reference Buffer. Connect this pin to AGND4.
K11	ADC_REFP	AO/A	Decoupling Capacitor Connection for ADC Reference Buffer. Connect this pin to a 4.7 µF capacitor to the ADC_REFN pin. ADC_REFP can be overdriven by an external reference.
H2	XTALO	O	Output from the Crystal Oscillator Inverter. When not using an external crystal, leave XTALO unconnected.
J2	XTALI	I	Input to the Crystal Oscillator Inverter and Input to the Internal Clock Generator Circuits. When not using an external crystal, connect XTALI to DGND.

[1] AI is analog input, AO is analog output, I is digital input, O is digital output, S is supply.

TYPICAL PERFORMANCE CHARACTERISTICS

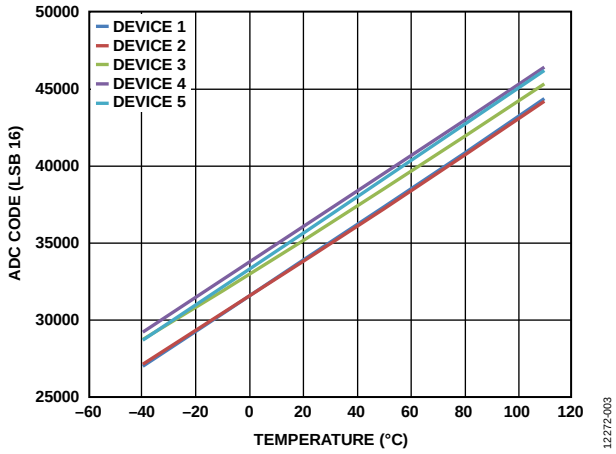


Figure 3. Typical Temperature Measurement vs. Internal Temperature (V_{DD} = 3.3 V, 50 kSPS)

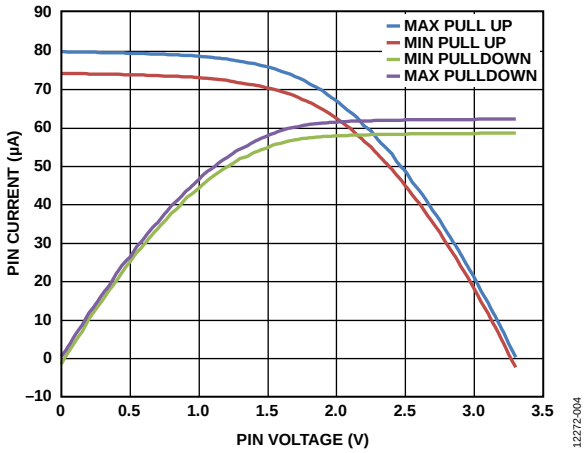


Figure 4. Typical Pull-Up/Pull-Down Pin Current vs. Pin Voltage (V_{DD} = 3.3 V, 25°C)

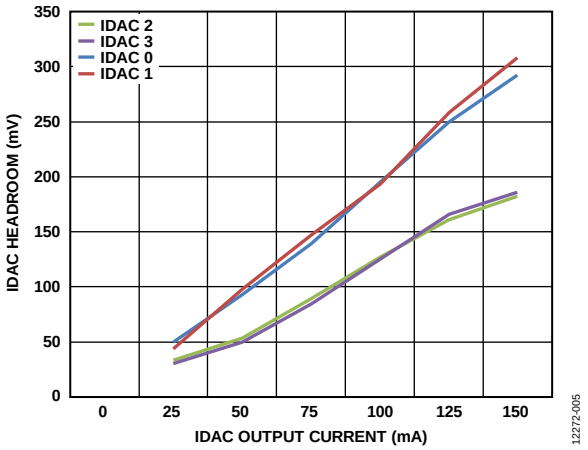


Figure 5. Typical IDAC Headroom vs. IDAC Output Current

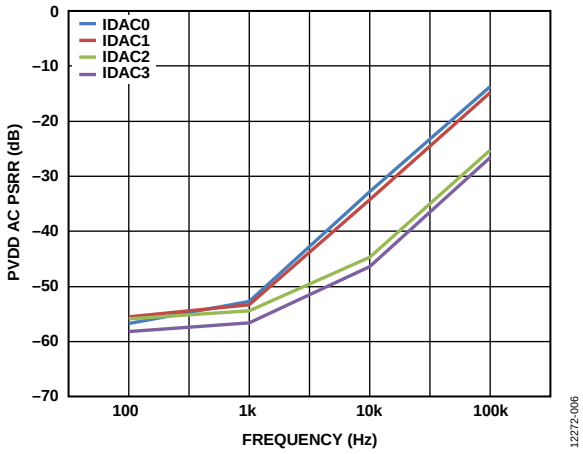


Figure 6. Typical PVDD AC PSRR vs. Frequency

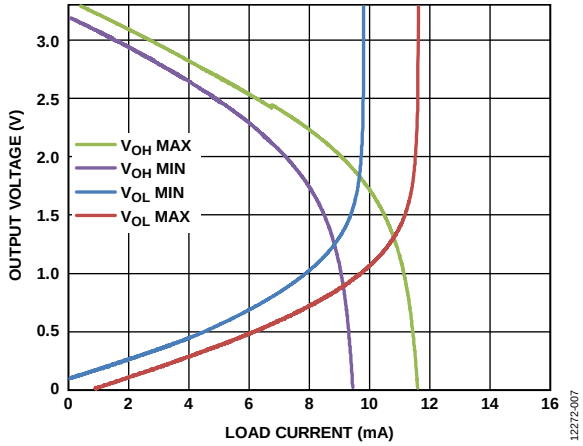


Figure 7. Typical Output Voltage vs. Load Current

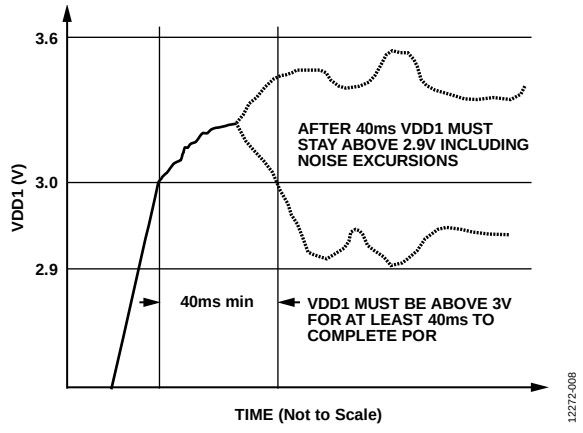


Figure 8. VDD1 Power-On Requirements

RECOMMENDED CIRCUIT AND COMPONENT VALUES

Figure 9 shows a typical connection diagram for the ADuCM320.

Supplies and regulators must be adequately decoupled with capacitors connected between the AVDDx, PVDDx, DVDD_x, AVDD_REGx, IOVDDx, and VDD1 balls and their associated GND balls (AGNDx, PGND, IOGNDx, and DGNDx). Table 3 indicates which ground balls are paired with which supply balls.

There are four digital supply balls, IOVDD1, IOVDD2, IOVDD3, and VDD1. Decouple these balls with a 100 nF capacitor placed as near as possible to each of the four balls and their associated GND balls (IOGNDx and AGND1, respectively). In addition, place a 10 µF capacitor conveniently near to these balls.

Similarly, the analog supply pins, AVDD3 and AVDD4, each require a 100 nF capacitor placed as near as possible to each ball and its associated AGNDx ball, and place a 10 µF capacitor conveniently near to these balls.

The IDACs source their output currents from the PVDDx supply balls. Each PVDDx supply ball must have a 100 nF capacitor near to each ball and their associated GND balls (PGND). In addition, place at least one 10 µF capacitor at the source of the PVDDx supply.

The IDAC output filters depend on a 10 nF capacitor being placed between the CDAMPx and PVDDx.

The ADC reference requires a 4.7 µF capacitor placed between ADC_REFP and ADC_REFN and located as near as possible to each ball. ADC_REFN must be connected directly to AGND4.

The ADuCM320 contains four internal regulators. These regulators require external decoupling capacitors. The DVDD_1V8 and DVDD_2V5 balls each require a 470 nF capacitor to DGND1 and IOGND3, respectively. AVDD_REG0 and AVDD_REG1 each require a decoupling capacitor to AGND4.

To generate an accurate and low drift reference current, connect the IREF ball to AGND4 via a low ppm 3.16 kΩ resistor.

Take care in the layout to ensure that currents flowing from the ground end of each decoupling capacitor to its associated ground ball share as little track as possible with other ground currents on the printed circuit board.

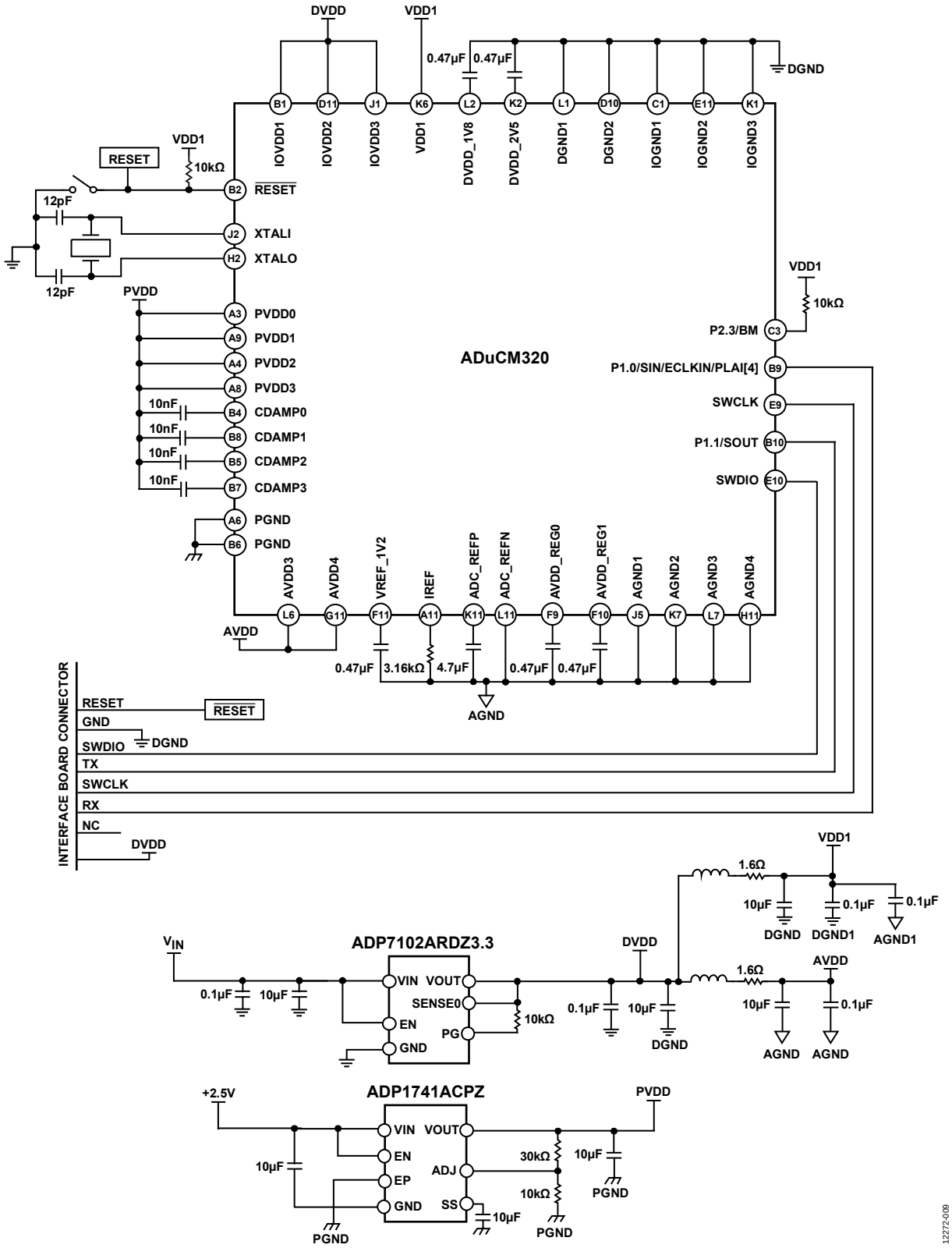


Figure 9. Recommended Circuit and Component Values

PACKAGING AND ORDERING INFORMATION

OUTLINE DIMENSIONS

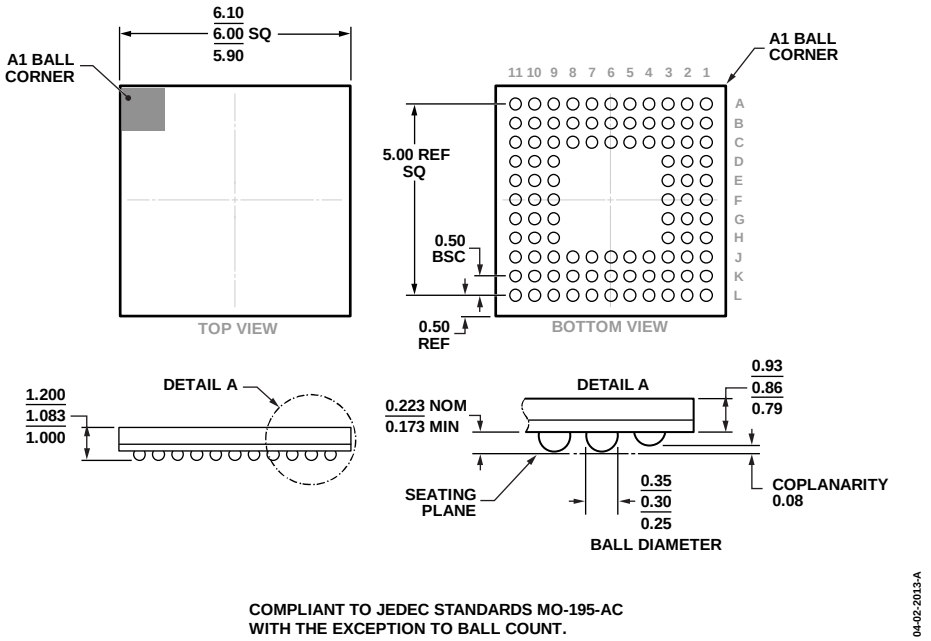


Figure 10. 96-Ball Chip Scale Package Ball Grid Array [CSP_BGA]
(BC-96-2)
Dimensions shown in millimeters

ORDERING GUIDE

Model[1]	Temperature Range	Package Description	Package Option	Ordering Quantity
ADuCM320BBCZ	−40°C to +85°C	96-Ball Chip Scale Package Ball Grid Array [CSP_BGA]	BC-96-2	429
ADuCM320BBCZ-RL	−40°C to +85°C	96-Ball Chip Scale Package Ball Grid Array [CSP_BGA]	BC-96-2	2,500
EV-ADuCM320QSPZ		Evaluation Board with QuickStart Development System		

[1] Z = RoHS Compliant Part.

I²C refers to a communications protocol originally developed by Philips Semiconductors (now NXP Semiconductors).